Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/082,081	LEE, CHULHEE
Examiner	Art Unit
Dave Czekaj	2621

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Previous Search	9/12/2006	DC	
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